

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10617363	WU ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	GERMAN VIANA DI PRISCO	2617

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	536	5/8/2009	GV

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO, and IBM_TDB (see attached search strategy)	5/8/2009	GV
Inventor name and Assignee search in PALM_ExPO and EAST	5/8/2009	GV
Consulted with Rafael Perez-Gutierrez	5/8/2009	GV
NPL search	5/8/2009	GV

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>